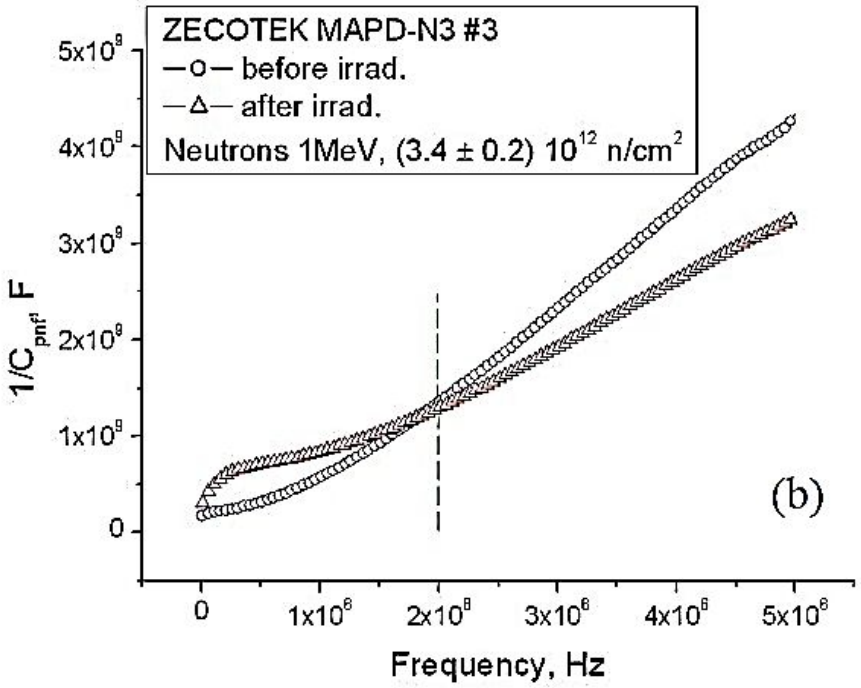
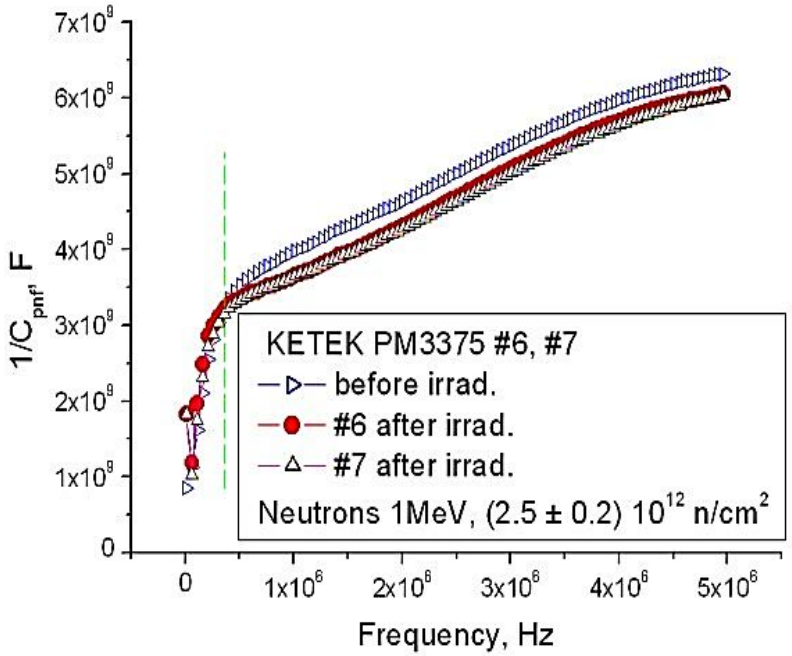
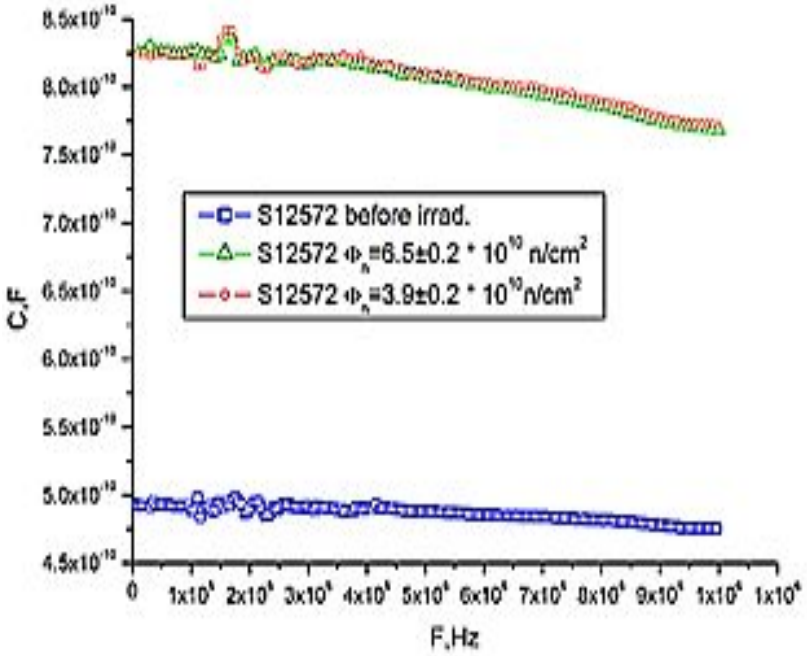
Особенности анализа частотной характеристики

$$\frac{\partial \Delta n}{\partial t} = \frac{1}{e} \cdot \frac{\partial J_n}{\partial x} + \frac{\Delta n}{\tau} \qquad (1)$$

$$\frac{1}{C}(f) = \frac{1}{e} \cdot \frac{\langle \tau \rangle}{\langle N_t \rangle} \cdot \Delta\varphi \cdot f \qquad (2)$$







C-F кривые Zecotek (слева), Ketek (центр) и Hamamatsu до и после облучения